

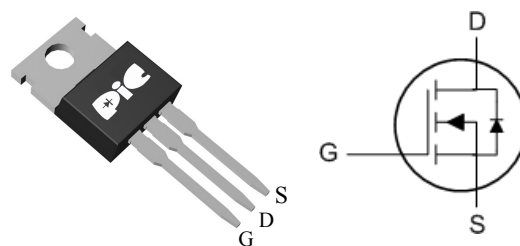
### ➤ General Description

This PAN60TG24AG N-Channel enhancement mode power field effect transistor is the high density trench technology and this advanced technology can provide excellent  $R_{ds(On)}$  performance and efficiency for power switching and load switching application., this device also comply with the RoHS and Green Product requirement with full function reliability approved.

### ➤ Feature

- Super Low Gate Charge
- 100% EAS Guaranteed
- Green Device Available
- Excellent  $CdV/dt$  effect decline
- Advanced high cell density Trench technology
- TO-220 package design

### ➤ TO-220



### ➤ Application

- SMPS Power Supplier.
- Charger Adapter
- Power Tools
- LED Lighting

### ➤ Absolute Maximum Ratings

| Parameter                                        | Symbol                  | Rating     | Units        |
|--------------------------------------------------|-------------------------|------------|--------------|
| Drain-Source Voltage                             | $V_{DS}$                | 60         | V            |
| Gate-Source Voltage                              | $V_{GS}$                | $\pm 20$   | V            |
| Continuous Drain Current, $V_{GS} @ 10V^{1,6}$   | $I_D @ T_C=25^\circ C$  | 170        | A            |
| Continuous Drain Current, $V_{GS} @ 10V^{1,6}$   | $I_D @ T_C=100^\circ C$ | 107        | A            |
| Continuous Drain Current, $V_{GS} @ 10V^1$       | $I_D @ T_A=25^\circ C$  | 15         | A            |
| Continuous Drain Current, $V_{GS} @ 10V^1$       | $I_D @ T_A=70^\circ C$  | 12         | A            |
| Pulsed Drain Current <sup>2</sup>                | $I_{DM}$                | 340        | A            |
| Single Pulse Avalanche Energy <sup>3</sup>       | EAS                     | 245        | mJ           |
| Avalanche Current                                | $I_{AS}$                | 70         | A            |
| Total Power Dissipation <sup>4</sup>             | $P_D @ T_C=25^\circ C$  | 260        | W            |
| Total Power Dissipation <sup>4</sup>             | $P_D @ T_A=25^\circ C$  | 2.02       | W            |
| Storage Temperature Range                        | $T_{STG}$               | -55 to 150 | $^\circ C$   |
| Operating Junction Temperature Range             | $T_J$                   | -55 to 150 | $^\circ C$   |
| Thermal Resistance Junction-Ambient <sup>1</sup> | $R_{\theta JA}$         | 62         | $^\circ C/W$ |
| Thermal Resistance Junction-Case <sup>1</sup>    | $R_{\theta JC}$         | 0.48       | $^\circ C/W$ |

### ➤ Electrical Characteristics ( $T_J=25^\circ C$ Unless otherwise noted)

| Parameter                                      | Symbol                       | Conditions                                                   | Min. | Typ.  | Max.      | Unit          |
|------------------------------------------------|------------------------------|--------------------------------------------------------------|------|-------|-----------|---------------|
| Drain-Source Breakdown Voltage                 | $BV_{DSS}$                   | $V_{GS}=0V$ , $I_D=250\mu A$                                 | 60   | ---   | ---       | V             |
| $BV_{DSS}$ Temperature Coefficient             | $\Delta BV_{DSS}/\Delta T_J$ | Reference to $25^\circ C$ , $I_D=1mA$                        | ---  | 0.058 | ---       | $V/^\circ C$  |
| Static Drain-Source On-Resistance <sup>2</sup> | $R_{DS(ON)}$                 | $V_{GS}=10V$ , $I_D=30A$                                     | ---  | ---   | 4.8       | $m\Omega$     |
| Gate Threshold Voltage                         | $V_{GS(th)}$                 | $V_{GS}=V_{DS}$ , $I_D=250\mu A$                             | 2.5  | ---   | 4.5       | V             |
| $V_{GS(th)}$ Temperature Coefficient           | $\Delta V_{GS(th)}$          |                                                              | ---  | -7.8  | ---       | $mV/^\circ C$ |
| Drain-Source Leakage Current                   | $I_{DSS}$                    | $V_{DS}=48V$ , $V_{GS}=0V$ , $T_J=25^\circ C$                | ---  | ---   | 1         | $\mu A$       |
|                                                |                              | $V_{DS}=48V$ , $V_{GS}=0V$ , $T_J=55^\circ C$                | ---  | ---   | 5         |               |
| Gate-Source Leakage Current                    | $I_{GSS}$                    | $V_{GS}=\pm 20V$ , $V_{DS}=0V$                               | ---  | ---   | $\pm 100$ | nA            |
| Forward Transconductance                       | $g_{fs}$                     | $V_{DS}=5V$ , $I_D=30A$                                      | ---  | 50    | ---       | S             |
| Gate Resistance                                | $R_g$                        | $V_{DS}=0V$ , $V_{GS}=0V$ , $f=1MHz$                         | ---  | 1.4   | ---       | $\Omega$      |
| Total Gate Charge (10V)                        | $Q_g$                        | $V_{DS}=48V$ , $V_{GS}=10V$ , $I_D=15A$                      | ---  | 83.7  | ---       | nC            |
| Gate-Source Charge                             | $Q_{gs}$                     |                                                              | ---  | 28.6  | ---       |               |
| Gate-Drain Charge                              | $Q_{gd}$                     |                                                              | ---  | 29.3  | ---       |               |
| Turn-On Delay Time                             | $T_{d(on)}$                  | $V_{DD}=30V$ , $V_{GS}=10V$ , $R_G=3.3\Omega$ ,<br>$I_D=48A$ | ---  | 38.1  | ---       | ns            |
| Rise Time                                      | $T_r$                        |                                                              | ---  | 73.3  | ---       |               |
| Turn-Off Delay Time                            | $T_{d(off)}$                 |                                                              | ---  | 51.6  | ---       |               |
| Fall Time                                      | $T_f$                        |                                                              | ---  | 26.1  | ---       |               |
| Input Capacitance                              | $C_{iss}$                    | $V_{DS}=15V$ , $V_{GS}=0V$ , $f=1MHz$                        | ---  | 5580  | ---       | pF            |
| Output Capacitance                             | $C_{oss}$                    |                                                              | ---  | 571   | ---       |               |
| Reverse Transfer Capacitance                   | $C_{rss}$                    |                                                              | ---  | 278   | ---       |               |

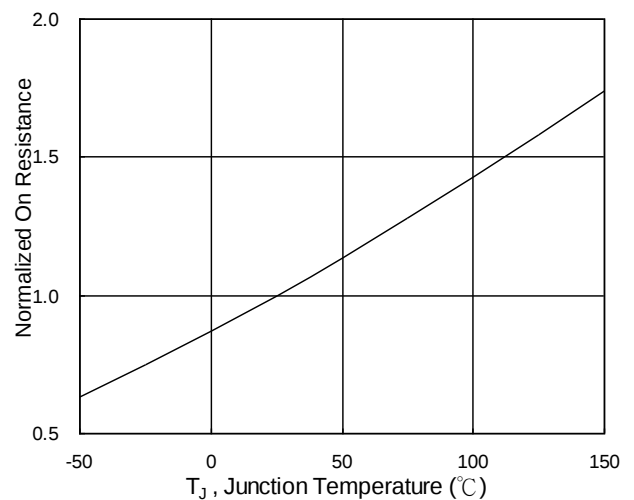
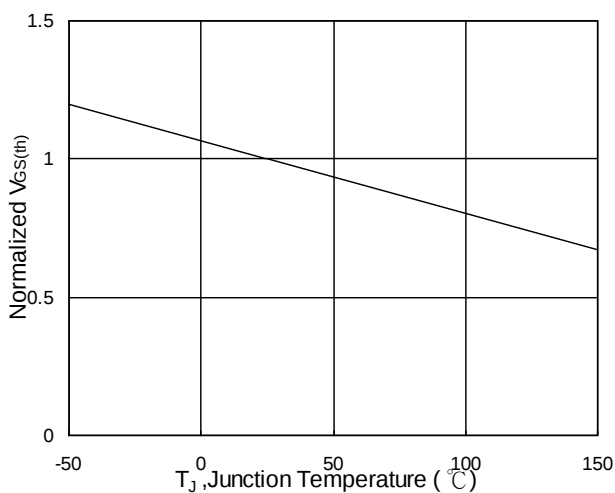
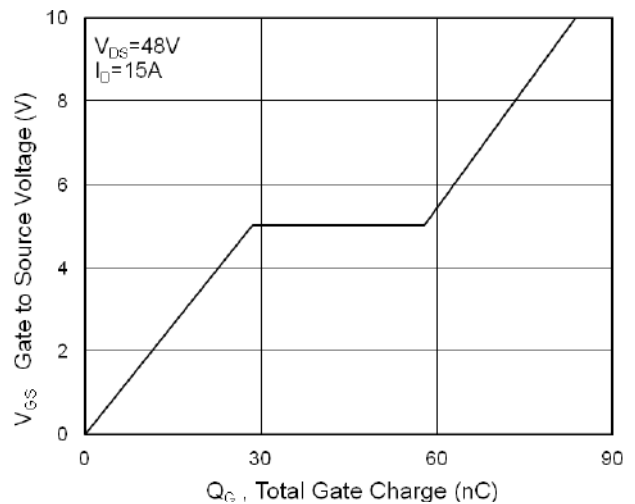
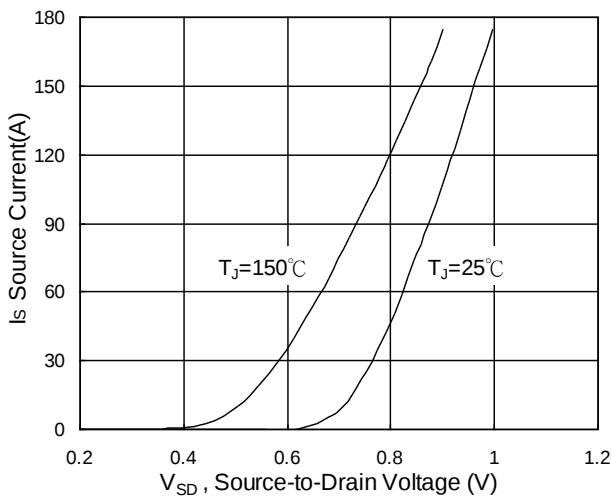
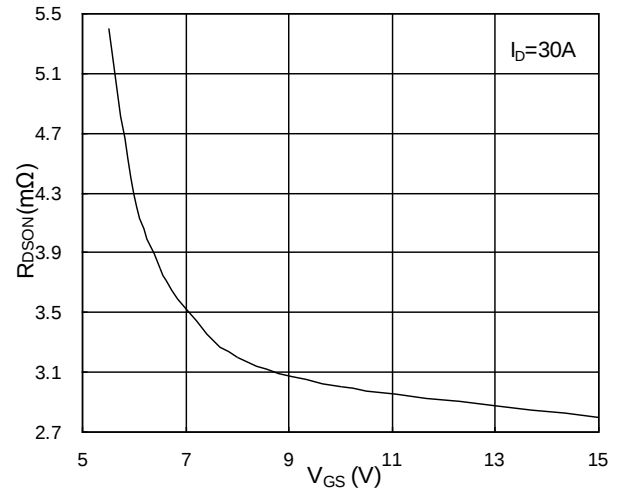
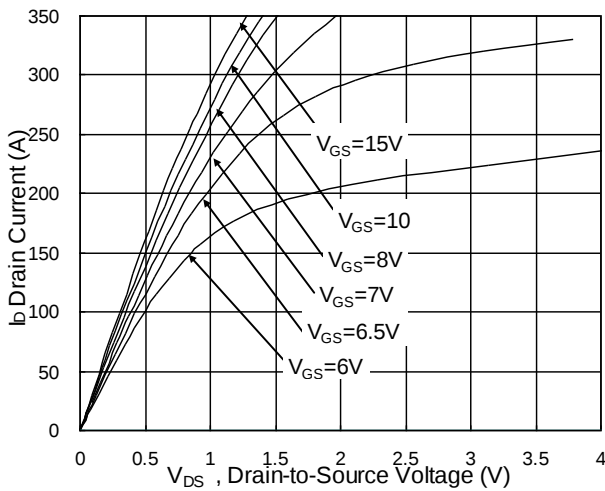
### ➤ Diode Characteristics

| Parameter                                | Symbol   | Conditions                                        | Min. | Typ. | Max. | Unit |
|------------------------------------------|----------|---------------------------------------------------|------|------|------|------|
| Continuous Source Current <sup>1,5</sup> | $I_S$    | $V_G=V_D=0V$ , Force Current                      | ---  | ---  | 170  | A    |
| Pulsed Source Current <sup>2,5</sup>     | $I_{SM}$ |                                                   | ---  | ---  | 340  | A    |
| Diode Forward Voltage <sup>2</sup>       | $V_{SD}$ | $V_{GS}=0V$ , $I_S=1A$ , $T_J=25^\circ C$         | ---  | ---  | 1.2  | V    |
| Reverse Recovery Time                    | $t_{rr}$ | $I_F=30A$ , $dI/dt=100A/\mu s$ , $T_J=25^\circ C$ | ---  | 27   | ---  | nS   |
| Reverse Recovery Charge                  | $Q_{rr}$ |                                                   | ---  | 28   | ---  | nC   |

Note :

1. Pulse width limited by maximum junction temperature.
2. The data tested by pulsed, pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$
3. The EAS data shows Max. rating. The test condition is  $V_{DD}=50V$ ,  $V_{GS}=10V$ ,  $L=0.1mH$ ,  $I_{AS}=70A$
4. Ensure that the channel temperature does not exceed  $150^\circ C$ .
5. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.
6. Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 120A.

### ➤ Typical Characteristics



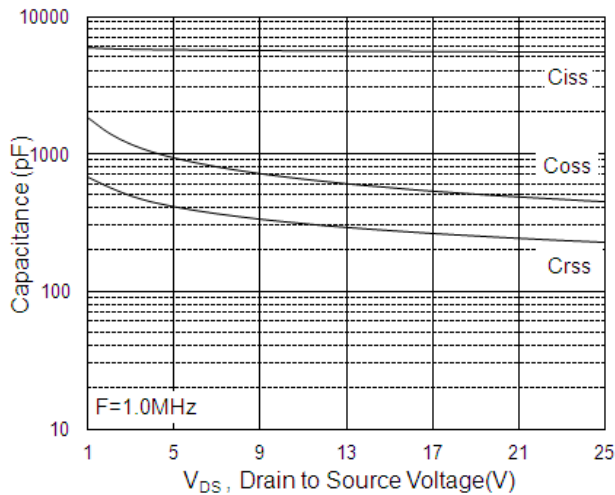


Fig.7 Capacitance

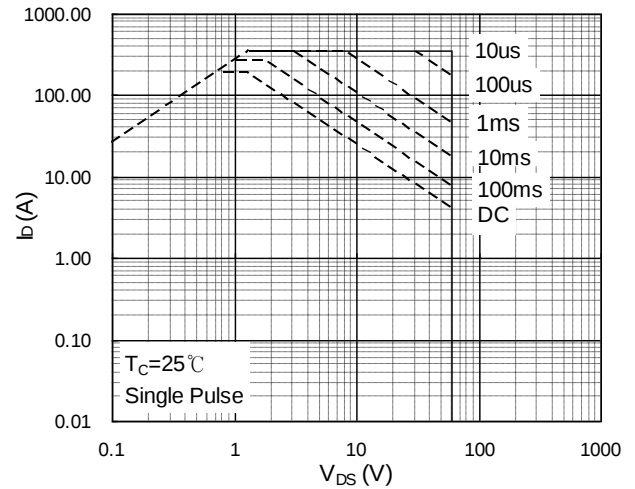


Fig.8 Safe Operating Area

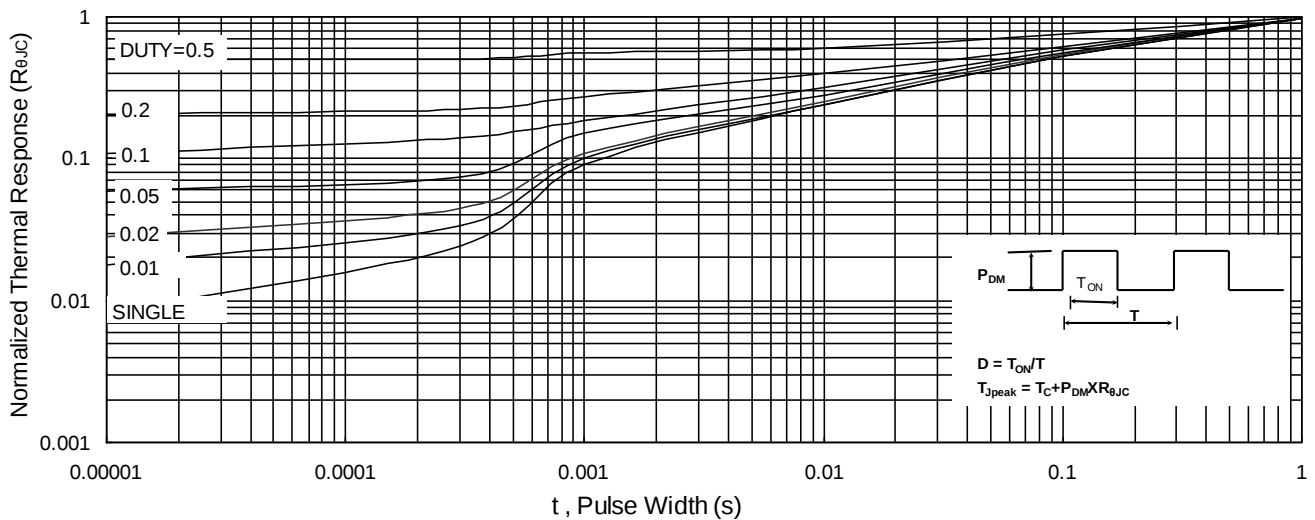


Fig.9 Normalized Maximum Transient Thermal Impedance

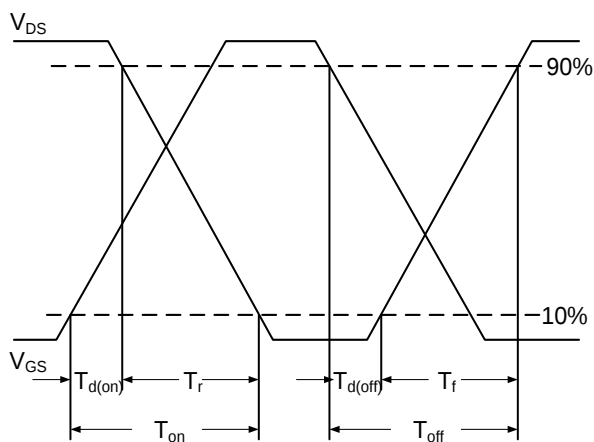


Fig.10 Switching Time Waveform

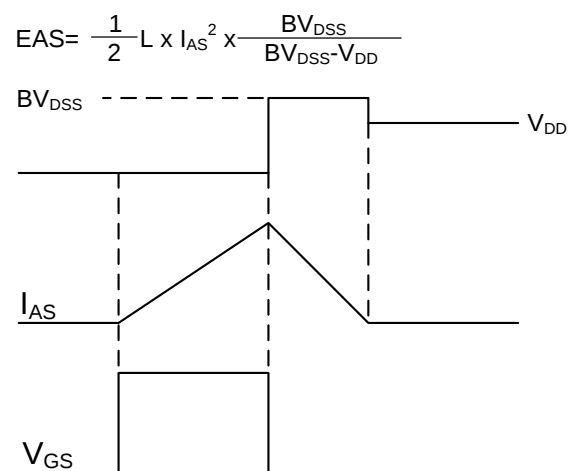


Fig.11 Unclamped Inductive Switching Waveform

### ➤ Recommend IR Reflow Soldering Thermal Profile

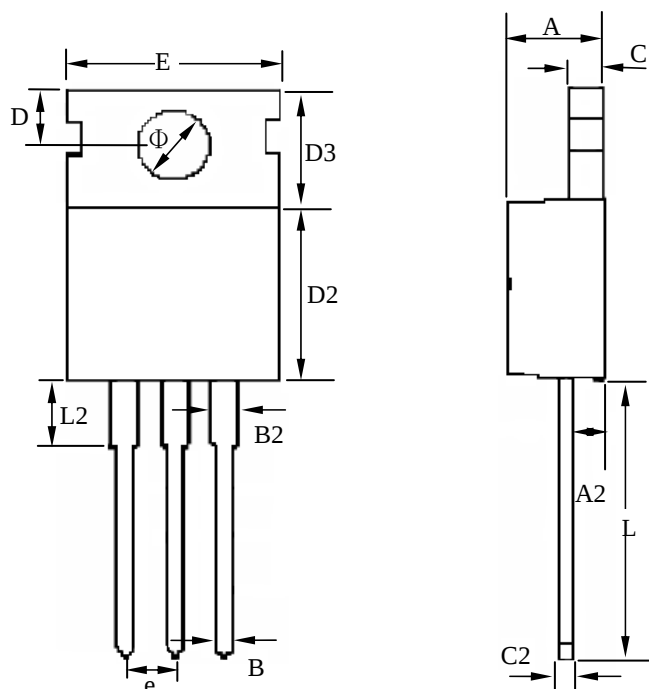


| Profile Feature                                      | Pb-Free Assembly Profile |
|------------------------------------------------------|--------------------------|
| Temperature Min. ( $T_{smin}$ )                      | 150°C                    |
| Temperature Max. ( $T_{smax}$ )                      | 200°C                    |
| Time ( $t_s$ ) from ( $T_{smin}$ to $T_{smax}$ )     | 60-120 seconds           |
| Average Ramp-up Rate ( $t_L$ to $t_P$ )              | 3°C/second max.          |
| Liquidous Temperature ( $T_L$ )                      | 217°C                    |
| Time ( $t_L$ ) Maintained Above ( $T_L$ )            | 60 – 150 seconds         |
| Peak Temperature                                     | 260°C +0°C / -5°C        |
| Time ( $t_P$ ) within 5°C of actual Peak Temperature | 30 seconds               |
| Ramp-down Rate ( $T_P$ to $T_L$ )                    | 6°C/second max           |
| Time 25°C to Peak Temperature                        | 8 minutes max.           |

### ➤ Ordering Information

| Part Number | Description | Quantity    |
|-------------|-------------|-------------|
| PAN60TG24AG | TO-220      | 50 pcs/tube |

### ➤ Package Information ( TO-220 )



| SYMBOLS | MILLIMETERS |      |       | INCHES |       |       |
|---------|-------------|------|-------|--------|-------|-------|
|         | MIN         | NOM  | MAX   | MIN    | NOM   | MAX   |
| A       | 4.25        | --   | 4.80  | 0.167  | --    | 0.189 |
| A2      | 2.20        | --   | 2.92  | 0.087  | --    | 0.115 |
| B       | 0.70        | --   | 0.91  | 0.028  | --    | 0.036 |
| B2      | 1.15        | --   | 1.77  | 0.045  | --    | 0.070 |
| C       | 1.20        | --   | 1.40  | 0.047  | --    | 0.055 |
| C2      | 0.45        | --   | 0.61  | 0.018  | --    | 0.024 |
| D       | 2.54        | --   | 3.00  | 0.100  | --    | 0.118 |
| D2      | 8.39        | --   | 9.47  | 0.330  | --    | 0.373 |
| D3      | 6.30        | --   | 6.70  | 0.248  | --    | 0.264 |
| E       | 9.70        | --   | 10.36 | 0.382  | --    | 0.408 |
| L       | 12.75       | --   | 14.40 | 0.502  | --    | 0.567 |
| L2      | 2.45        | --   | 4.05  | 0.096  | --    | 0.159 |
| Φ       | 3.50        | --   | 3.80  | 0.138  | --    | 0.150 |
| e       | --          | 2.54 | --    | --     | 0.100 | --    |

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